Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/683,962	FU, YEE-CHUNG
Examiner	Art Unit
Seung H. Lee	2876

	SEARCHED		
Class	Subclass	Date	Examiner
235	454	3/28/2005	SHL
216	2	3/28/2005	SHL
310	309	3/28/2005	SHL

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	1		

SEA (INCLUDING :	RCH NOTES SEARCH STRATEG	Y)
	DATE	EXMR
EAST	3/28/2005	SHL
NPL	3/28/2005	SHL
K. Frech (235)	3/28/2005	SHL
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